

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10616525	FUNK ET AL.
Examiner	Art Unit	
Rutten, J. Derek	2192	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
717/127-130; 714/34,35 (Updated text search - see search history printout)	7/6/07	/jdr/
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT - see search history printout)	7/6/07	/jdr/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner